

Substitute for form 1449/PTO (Revised 07/2007) INFORMATION DISCLOSURE STATEMENT BY APPLICANT <i>(Use as many sheets as necessary)</i>				Complete if Known	
				Application Number	10/583,570
				Filing Date	March 5, 2007
				First Named Inventor	DeSimone
				Art Unit	1791
				Examiner Name	Not Yet Assigned
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Substitute for form 1449/PTO (Revised 07/2007) INFORMATION DISCLOSURE STATEMENT BY APPLICANT <i>(Use as many sheets as necessary)</i>				Complete if Known	
				Application Number	10/583,570
				Filing Date	March 5, 2007
				First Named Inventor	DeSimone
				Art Unit	1791
				Examiner Name	Not Yet Assigned
Sheet	9	of	10	Attorney Docket Number	035052/338899

OTHER DOCUMENTS			
Examiner Initials*	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	English Language Translation Attached
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